

Class Imbalance Reduction and Centroid based Relevant Project Selection for Cross Project Defect Prediction

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Abstract— Cross-Project Defect Prediction (CPDP) is the process of predicting defects in a target project using information from other projects. This can assist developers in prioritizing their testing efforts and finding flaws. Transfer Learning (TL) has been frequently used at CPDP to improve prediction performance by reducing the disparity in data distribution between the source and target projects. Software Defect Prediction (SDP) is a common study topic in software engineering that plays a critical role in software quality assurance. To address the cross-project class imbalance problem, Centroid-based PF-SMOTE for Imbalanced data is used. In this paper, we used a Centroid-based PF-SMOTE to balance the datasets and Centroid based relevant data selection for Cross Project Defect Prediction. These methods use the mean of all attributes in a dataset and calculating the difference between mean of all datasets. For experimentation, the open source software defect datasets namely, AEEM, Re-Link, and NASA, are considered.

Keywords- Cross Project Defect Prediction; Class imbalance; PF-SMOTE; Software quality assurance.

I. INTRODUCTION

The popularity of software is rising dramatically in the present day. Customers won't be satisfied unless the software is flawless. Therefore, it is essential to check the software modules at the beginning of the process before proceeding to further stages. In order to determine whether there are any defects in the programme, it must be tested during the testing process. Using classification models created from past defect data from other projects, CPDP refers to the identification of potentially defect-prone modules in a project (i.e., target). There is typically a significant distribution mismatch between source and target projects since the programming languages, coding styles, and developer experience are different [1], [2]. Different issues can arise as a result of software flaws. Manual testing and code review are typical methods for locating software flaws. These techniques' fundamental flaw is that it takes a lot of time and effort to use them. By using automatic methods for Software Defect Prediction (SDP), one can cut costs while raising the calibre of software projects. Software Defect Prediction is a significant issue in the research of programming languages and software

engineering. The objective is to accurately locate the defective code (in terms of the precision and recall) [3]. The majority of SDP techniques fall under the category of Within-Project Defect Prediction (WPDP), which creates a classification model using past data on defects to determine how prone to errors new software modules are within the same project [4], [5], [6], [7]. Although the aforementioned approaches have demonstrated the good CPDP prediction performance, there are a few limitations: Problems with parameter adjustment, cross-project class imbalance, and data selection [8]. In this paper, we used a Centroid-based PF-SMOTE to balance the datasets [31] and Centroid based relevant data selection for Cross Project Defect Prediction. The remaining sections are organized as follows: In Section II, the related work is reviewed. Section III details the recommended strategy. The experimental results are presented in Section IV. Finally, Section V presents the conclusions.

II. RELATED WORK

The common software defect prediction methodology and the associated cross-project defect prediction techniques are briefly reviewed in this section.

A. Process for Predicting Software Defects

The goal of software defect prediction is to identify more frequently defective modules and make it possible for the organization's limited resources to be wisely distributed. The majority of the currently used defect prediction algorithms are based on machine learning methods [9], [10], which build prediction models using historical data on defects and then forecast the fault labels of unlabeled software modules.

B. Methods for Cross-Project Defect Prediction

Cross-project defect prediction uses the trained model with external project data to identify more likely defect-prone modules in a target project. CPDP has attracted the attention of an increasing number of academics in the field of software engineering [11], [12], [13]. A number of novel CPDP models have been created in recent years [14], [15], [16], [17]. Existing CPDP models can be split into two categories: training data selection based CPDP methods and transfer learning based CPDP methods.

C. Training data selection based CPDP methods

Finding the best training data for the target project data is the goal of training data selection-based CPDP algorithms [2]. The distribution gap between the source and target data can be minimized since the chosen source modules are comparable to the target project's modules.

D. Transfer learning based CPDP methods

Designing efficient algorithms with excellent generalization capabilities is the goal of transfer learning-based CPDP approaches [18], [19], [20], [21]. The majority of CPDP approaches concentrate on learning new metric representations for the source and target data in order to explicitly reduce the distribution difference between them and maybe bring the source's data distribution closer to the target's. Ma et al. [19] integrated transfer learning approach into CPDP and developed a transfer naive bayes method, which primarily transfers weight information from the source into the target, to reduce the distribution gap between the source and target data.

Other CPDP approaches [22], [23], [24], [25] focus on mixed-project defect prediction. However, these methods require a small number of tagged modules from the target project, which limits their application in the broader CPDP situation. Ryu et al. [26] applied a boosting-based model called value-cognitive boosting with support vector machine to the class imbalance

problem in a cross-project defect prediction environment. Jing et al. [27] developed the SSTCA+ISDA method for dealing with the cross-project class imbalance problem by combining semi-supervised transfer component analysis with an improved subclass discriminant analysis algorithm.

E. Limitations of existing CPDP methods

Although the CPDP approaches detailed in the preceding section have made significant progress, there is still much opportunity for improvement. We discovered that the majority of existing CPDP approaches [2], [18], [28], [27], [20], [29] do not take into account the peculiarities of the defect prediction data (i.e., inconsistent distribution, class imbalance) and the hyper parametric optimization problem at the same time. Some of the training data selection-based CPDP approaches concentrate on picking relevant source data for the target at the module level. Instead of selecting similar projects with varying granularities at the project level, the other techniques chose similar projects with different granularities at the project level. However, these strategies simply took into account the inconsistency of the data distribution. The maximum mean discrepancy (MMD) [30] measure is used to directly calculate the similarity of source and target projects for unsupervised training data selection.

III. PROPOSED METHOD

In this section, we will go over the specifics of the proposed method, i.e., Class Imbalance Reduction and Centroid based relevant data selection for Cross Project Defect Prediction. To assess the efficacy of the examined techniques, AEEM, NASA and RELINK open source software defect datasets are taken into consideration for experimentation. The proposed architecture is given in Fig. 1.

A. Proposed Method

If the samples in the datasets are distributed unevenly i.e; majority and minority classes, occurs. To accomplish this, create synthetic samples. In this paper, we have considered the open source datasets such as AEEM, NASA and RELINK from different source projects. Preprocessing is a crucial step as we gather the datasets that must be altered in order for the algorithm to interpret them. The process is demonstrated below. The class label attribute of the source project is having values Y/N, T/F are changed to 1/0. As datasets are belonging to different projects, the software metrics may be considered different. So, to apply classification models the datasets should contain same type of metrics as attributes. We choose common attributes from the datasets for classification.

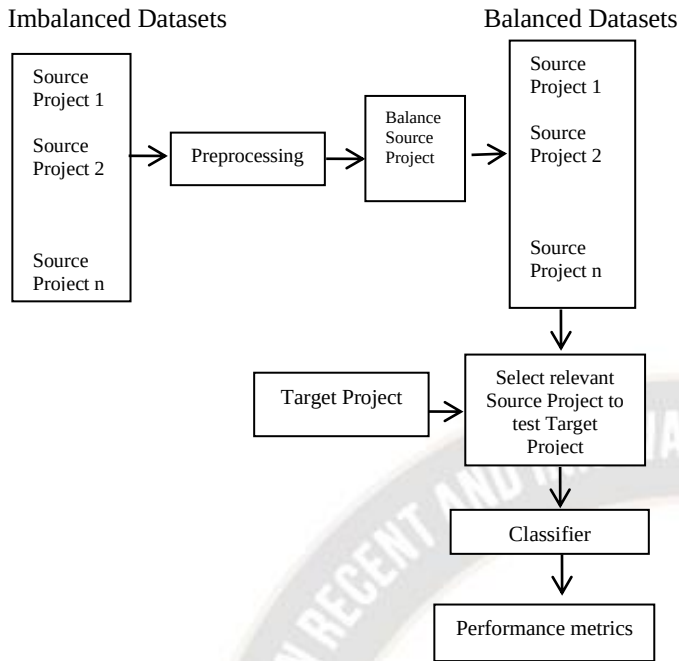


Fig. 1. Architecture of Proposed Method

B. Balance Source Projects

The datasets must be balanced during the training and testing phases. Section C describe the procedure used to balance the datasets.

C. Algorithm1: Balancing the datasets

Input: Minority class samples DSmin, Majority class samples DSmaj

Output: Synthetic samples Sg

1: DSmin_safe ← NULL, DSmin_bound ← NULL

2: Calculate the Centroid of DSmin

3: Find k - nearest neighbours from Centroid

4: for each nearest neighbour ynn

4.1: if ynn ∈ DSmin then

4.2: DSmin_safe ← DSmin_safe U yi

4.3: else if ynn ∈ DSmaj then

4.4: DSmin_bound ← DSmin_bound U yi

end if

end for

5: Ssafe_g ← NULL

6: for all yi ∈ Ssafe_g, do

6.1: Find the local safe region LSR yi

6.2: Randomly select the sample ysafe ∈ LSR

6.3: generate synthetic samples Ssafe_g using

$$Ssafe_g = yi + \text{random number between } 0 \text{ and } 1 \times (y_{safe} - yi)$$

6.4: Ssafe_g ← Ssafe_g U Ssafe_g

end for

7: Sbound_g ← NULL

8: for all yi ∈ DSmin_bound, do

8.1: Find its nearest majority class sample ynn- ∈ DSmaj

8.2: generate synthetic samples Sboundg using

$$Ssafeg = yi + \text{random number between } 0 \text{ and } 1 \times (y_{safe} - yi)$$

8.3: Sbound_g ← Sbound_g U Sbound_g

end for

9: return Sg ← Ssafe_g U Sbound_g

D. Algorithm 2: Selection of relevant source project

Select the relevant source project to test the target project. The means of the datasets are first calculated in the suggested method, and the distance between the means of each dataset is then determined. The pseudo code for the suggested approach is given in section E.

E. Centroid based relevant project selection

Let $P_1, P_2, \dots, P_n$ be the projects and $DS_1, DS_2, \dots, DS_m$ be the datasets in each project P_i where $1 \leq i \leq n$.

Each dataset DS_j where $1 \leq j \leq m$ has $r_1, r_2, \dots, r_p$ records with $a_1, a_2, \dots, a_x$ attributes and $r_m a_n$ represents value of m^{th} row n^{th} column.

for each group of datasets belongs to same project :

Compute Centroid of each data set using $C = (\sum r_m a_n) / p$

Compute Euclidean distance between C and r_j where $1 \leq j \leq p$

Sort the distances in ascending order

Choose minimum distance dataset for training and testing

End for

F. Performance metrics

Accuracy, Precision, Recall, F-Measure, Specificity, Geometric Mean, Confusion matrix and AUC are some of the several performance metrics. The equations (1) to (7) show the metrics' formulae.

$$\text{Accuracy (ACC)} = \frac{TN + TP}{TP + FP + TN + FN} \quad (1)$$

$$\text{Precision (PRE)} = \frac{TP}{TP + FP} \quad (2)$$

$$\text{Recall (REC)} = \frac{TP}{TP + FN} \quad (3)$$

$$\text{F-Measure (FM)} = \frac{2 * \text{Precision} * \text{Recall}}{\text{Precision} + \text{Recall}} \quad (4)$$

$$\text{Specificity (SPEC)} = \frac{TN}{TN + FP} \quad (5)$$

$$\text{Geometric Mean (GM)} = \sqrt{\frac{\text{Recall} * \text{Specificity}}{2}} \quad (6)$$

$$\text{AUC} = \frac{TP}{TP + FN} \quad (7)$$

IV. EXPERIMENTAL RESULTS

This part aims to demonstrate the efficiency and dependability of the suggested solution, which is Class Imbalance Reduction (CIR) and Centroid based relevant project selection for Cross Project Defect Prediction. We considered the eight classifiers like Decision Tree, Logistic Regression, KNN, Naive Bayes, AdaBoost, Extra Tree, and SVM algorithms. Table I displays the imbalance ratio's of various datasets of the projects.

After applying Centroid based relevant project selection on the balanced datasets of each project shown in Table I, the minimum distances of mean values are shown in Table II to Table IV in bold face.

Table I: The Datasets Under Consideration

Project	Test dataset (TS)	Train dataset (TR)
AEEM	EQ	LUCENE
	JDT	MYLYN
	LUCENE	JDT
	MYLYN	PDE
	PDE	MYLYN
NASA	KC3	MC2
	MC2	KC3
	PC3	PC4
	PC4	PC3
RELINK	APACHE	SAFE
	SAFE	ZXING
	ZXING	SAFE

Table II. Distances Between Means of Datasets of AEEM Project

	EQ	JDT	LUCENE	MYLYN	PDE
EQ	0	639.30	24.85	43.90	28.71
JDT	639.30	0	681.0	629.68	658.25
LUCENE	24.85	629.68	0	56.48	33.16
MYLYN	43.90	681.0	56.48	0	33.13
PDE	28.71	658.25	33.16	33.13	0

Table III. Distances Between Means of Datasets of NASA Project

	KC3	MC2	PC3	PC4
KC3	0	41244.17	58410.26	49169.92
MC2	41244.17	0	91523.3	85953.74
PC3	58410.26	91523.35	0	13867.99
PC4	49169.9	85953.74	13867.9	0

Table IV. Distances Between Means of Datasets of RELINK Project

	APACHE	SAFE	ZXING
APACHE	0	6.64	6.68
SAFE	6.64	0	1.71
ZXING	6.64	1.71	0

The results shown in Table II to Table IV are used to select the source and target projects which are used to train and test the datasets, which are shown in Table V.

Table V. Training and Test Datasets

Project	Test dataset (TS)	Train dataset (TR)
AEEM	EQ	LUCENE
	JDT	MYLYN
	LUCENE	JDT
	MYLYN	PDE
	PDE	MYLYN
NASA	KC3	MC2
	MC2	KC3
	PC3	PC4
	PC4	PC3
RELINK	APACHE	SAFE
	SAFE	ZXING
	ZXING	SAFE

Upon choosing relevant project for training and test the datasets, various classification algorithms like Decision Tree, Logistic Regression, KNN, Naive Bayes, AdaBoost, Extra Tree, and SVM are used to calculate the performance measures using the equations 1 to 7. The results of our experiments are shown in table VI to table XII.

The experimentation results after applying AdaBoost algorithm on the datasets is shown in Table VI. It shows that, except some metrics most of the metrics are giving good performance for the combination of test and train datasets shown in table V.

The experimentation results after applying Decision tree algorithm on the datasets is shown in Table VII. It shows that, except some metrics most of the metrics are giving good performance for the combination of test and train datasets shown in table V.

The experimentation results after applying Extra Tree algorithm on the datasets is shown in Table VIII. It shows that, except some metrics most of the metrics are giving good performance for the combination of test and train datasets shown in table V.

The experimentation results after applying KNN algorithm on the datasets is shown in Table IX. It shows that, except some metrics most of the metrics are giving good performance for the combination of test and train datasets shown in table V.

The experimentation results after applying Logistic Regression algorithm on the datasets is shown in Table X. It shows that, except some metrics most of the metrics are giving good performance for the combination of test and train datasets shown in table V.

The experimentation results after applying Naïve bayes on the datasets is shown in Table XI. It shows that, except some metrics most of the metrics are giving good performance for the combination of test and train datasets shown in table V.

The experimentation results after applying SVM algorithm on the datasets is shown in Table XII. It shows that, except some metrics most of the metrics are giving good performance for the combination of test and train datasets shown in Table V.

Table VI. Comparison of Performance Metrics Using AdaBoost Algorithm

TS	TR	ACC	PRE	REC	FM	SPEC	GM	AUC
EQ	LUCEN E	0.66	0.85	0.17	0.28	0.98	0.49	0.58
	JDT	0.65	0.85	0.13	0.23	0.98	0.36	0.56
	MYLYN	0.66	0.71	0.26	0.38	0.93	0.49	0.6
	PDE	0.65	0.69	0.22	0.33	0.93	0.45	0.58
JDT	LUCEN E	0.71	0.35	0.5	0.41	0.47	0.62	0.63
	EQ	0.41	0.25	0.96	0.4	0.27	0.51	0.61
	MYLYN	0.93	0.6	0.51	0.55	0.91	0.69	0.71
	PDE	0.78	0.47	0.57	0.52	0.83	0.69	0.70
LUCEN E	EQ	0.91	0.48	0.8	0.33	0.98	0.62	0.64
	JDT	0.91	0.48	0.23	0.34	0.98	0.47	0.65
	MYLYN	0.89	0.27	0.09	0.14	0.97	0.3	0.53
	PDE	0.82	0.21	0.36	0.27	0.86	0.56	0.61
MYLYN	PDE	0.88	0.37	0.32	0.27	0.97	0.55	0.59
	EQ	0.3	0.13	0.73	0.22	0.23	0.41	0.48
	JDT	0.85	0.36	0.16	0.22	0.96	0.39	0.56
	LUCEN	0.63	0.17	0.45	0.25	0.66	0.54	0.56

PDE	E							
	EQ	0.5	0.17	0.68	0.27	0.47	0.57	0.58
	JDT	0.86	0.48	0.17	0.25	0.97	0.41	0.57
	LUCEN E	0.84	0.35	0.21	0.26	0.94	0.44	0.57
KC3	MYLYN	0.87	0.50	0.74	0.38	0.97	0.58	0.63
	MC2	0.87	0.29	0.22	0.24	0.89	0.42	0.55
	PC3	0.81	0	0	0	1	0	0.5
MC2	PC4	0.76	0.29	0.19	0.23	0.89	0.41	0.54
	KC3	0.66	0.25	0.07	0.11	0.89	0.25	0.48
	PC3	0.65	0	0	0	1	0	0.5
PC3	PC4	0.59	0.23	0.07	0.11	0.88	0.25	0.47
	PC4	0.88	0.26	0.14	0.18	0.94	0.36	0.54
	KC3	0.87	0.23	0.02	0.04	0.93	0.14	0.51
PC4	MC2	0.86	0.05	0.01	0.02	0.92	0.1	0.49
	PC3	0.86	0.7	0.07	0.11	0.98	0.26	0.52
	KC3	0.85	0.5	0.01	0.02	0.9	0.1	0.5
APACH E	MC2	0.86	0.67	0.01	0.02	0.92	0.1	0.51
	SAFE	0.7	0.69	0.73	0.71	0.76	0.69	0.7
	ZXING	0.53	0.56	0.36	0.44	0.71	0.51	0.53
SAFE	ZXING	0.68	0.64	0.41	0.5	0.85	0.59	0.63
	APACH E	0.67	0.6	0.47	0.41	0.82	0.51	0.62
ZXING	SAFE	0.76	0.48	0.36	0.39	0.9	0.53	0.57
	APACH E	0.7	0.47	0.06	0.11	0.89	0.24	0.52

Table VII. Comparison of Performance Metrics Using Decision Tree Algorithm

TS	TR	ACC	PRE	REC	FM	SPEC	GM	AUC
EQ	LUCE NE	0.67	0.71	0.23	0.47	0.94	0.48	0.69
	JDT	0.58	0.46	0.29	0.36	0.77	0.47	0.53
	MYL YN	0.67	0.68	0.34	0.45	0.89	0.55	0.62
	PDE	0.59	0.47	0.26	0.33	0.8	0.46	0.53
JDT	LUCE NE	0.62	0.3	0.64	0.41	0.62	0.63	0.63
	EQ	0.47	0.25	0.81	0.38	0.38	0.55	0.59
	MYL YN	0.67	0.37	0.62	0.43	0.66	0.69	0.69
	PDE	0.54	0.28	0.74	0.41	0.49	0.6	0.62
LUC ENE	EQ	0.5	0.12	0.7	0.2	0.48	0.58	0.59
	JDT	0.85	0.24	0.39	0.29	0.9	0.59	0.59
	MYL YN	0.84	0.24	0.34	0.28	0.89	0.55	0.62
	PDE	0.71	0.14	0.39	0.21	0.75	0.54	0.57
MY LYN	PDE	0.86	0.19	0.59	0.37	0.89	0.58	0.59
	EQ	0.4	0.11	0.51	0.18	0.39	0.45	0.45
	JDT	0.62	0.14	0.37	0.2	0.66	0.49	0.51
	LUCE NE	0.81	0.13	0.32	0.31	0.88	0.53	0.58

PDE	EQ	0.39	0.13	0.61	0.21	0.36	0.47	0.49
	JDT	0.78	0.27	0.32	0.29	0.86	0.52	0.59
	LUCE NE	0.8	0.31	0.37	0.34	0.87	0.57	0.62
	MYL YN	0.85	0.32	0.38	0.39	0.89	0.58	0.69
KC3	MC2	0.85	0.28	0.53	0.3	0.98	0.54	0.61
	PC3	0.76	0.25	0.14	0.18	0.91	0.36	0.52
	PC4	0.84	0.27	0.19	0.3	0.98	0.43	0.59
MC2	KC3	0.64	0.35	0.39	0.47	0.92	0.59	0.57
	PC3	0.62	0.44	0.36	0.4	0.75	0.52	0.56
	PC4	0.6	0.31	0.11	0.16	0.86	0.31	0.49
PC3	PC4	0.82	0.24	0.21	0.22	0.91	0.44	0.56
	KC3	0.35	0.1	0.5	0.17	0.33	0.41	0.41
	MC2	0.76	0.11	0.13	0.12	0.85	0.33	0.49
PC4	PC3	0.82	0.21	0.16	0.19	0.91	0.38	0.54
	KC3	0.32	0.11	0.12	0.19	0.28	0.42	0.45
	MC2	0.72	0.05	0.08	0.06	0.8	0.25	0.44
AP AC HE	SAFE	0.64	0.61	0.78	0.68	0.5	0.62	0.64
	ZXIN G	0.56	0.55	0.72	0.62	0.3	0.53	0.55
SA FE	ZXIN G	0.77	0.76	0.68	0.69	0.9	0.75	0.75
	APAC HE	0.68	0.75	0.27	0.4	0.9	0.5	0.61
ZXI NG	SAFE	0.7	0.49	0.35	0.37	0.7	0.52	0.56
	APAC HE	0.69	0.44	0.18	0.26	0.6	0.4	0.54

PDE	JDT	0.74	0.18	0.29	0.22	0.81	0.48	0.55
	LUCE NE	0.76	0.26	0.45	0.33	0.81	0.6	0.63
	EQ	0.58	0.17	0.54	0.26	0.59	0.56	0.56
	JDT	0.8	0.25	0.22	0.23	0.89	0.44	0.56
KC3	LUCE NE	0.8	0.24	0.2	0.22	0.9	0.42	0.55
	MYL YN	0.82	0.3	0.4	0.27	0.9	0.57	0.59
	MC2	0.86	0.29	0.53	0.36	0.77	0.57	0.59
MC2	PC3	0.81	0	0	0	1	0	0.5
	PC4	0.7	0.28	0.42	0.34	0.76	0.56	0.59
	KC3	0.77	0.53	0.66	0.52	0.82	0.59	0.59
PC3	PC3	0.66	0.52	0.39	0.45	0.8	0.56	0.59
	PC4	0.47	0.31	0.41	0.35	0.51	0.46	0.46
	MC2	0.77	0.53	0.66	0.52	0.82	0.59	0.59
PC4	PC3	0.78	0.21	0.27	0.34	0.85	0.69	0.71
	KC3	0.59	0.21	0.82	0.33	0.56	0.68	0.69
	MC2	0.36	0.13	0.74	0.22	0.31	0.48	0.52
AP AC HE	PC3	0.83	0.24	0.27	0.2	0.93	0.44	0.55
	KC3	0.81	0.03	0.02	0.02	0.92	0.14	0.47
	MC2	0.76	0.16	0.22	0.19	0.84	0.43	0.53
SA FE	SAFE	0.68	0.67	0.71	0.69	0.65	0.68	0.68
	ZXIN G	0.62	0.62	0.61	0.61	0.62	0.61	0.62
ZXI NG	ZXIN G	0.73	0.77	0.64	0.65	0.89	0.71	0.72
	APAC HE	0.73	0.71	0.55	0.62	0.85	0.68	0.7
AP AC HE	SAFE	0.69	0.43	0.44	0.42	0.87	0.57	0.58
	APAC HE	0.68	0.42	0.23	0.3	0.87	0.45	0.55

Table VIII. Comparison of Performance Metrics Using Extra Tree Algorithm

TS	TR	ACC	PRE	REC	FM	SPE C	GM	AUC
EQ	LUCE NE	0.64	0.7	0.15	0.35	0.96	0.48	0.55
	JDT	0.58	0.44	0.23	0.3	0.81	0.43	0.52
	MYL YN	0.58	0.44	0.19	0.27	0.84	0.4	0.51
	PDE	0.56	0.42	0.29	0.34	0.73	0.46	0.51
JDT	LUCE NE	0.67	0.23	0.45	0.44	0.85	0.62	0.65
	EQ	0.43	0.22	0.7	0.33	0.36	0.5	0.53
	MYL YN	0.67	0.28	0.38	0.52	0.87	0.63	0.66
	PDE	0.58	0.25	0.52	0.34	0.6	0.56	0.56
LUC ENE	EQ	0.55	0.09	0.42	0.15	0.56	0.48	0.49
	JDT	0.86	0.24	0.46	0.29	0.88	0.6	0.62
	MYL YN	0.85	0.22	0.23	0.22	0.82	0.46	0.58
	PDE	0.8	0.21	0.41	0.28	0.84	0.59	0.62
MYL YN	PDE	0.77	0.29	0.34	0.34	0.88	0.61	0.66
	EQ	0.3	0.11	0.63	0.19	0.25	0.4	0.44

Table IX. Comparison of Performance Metrics Using KNN Algorithm

TS	TR	ACC	PRE	REC	FM	SPE C	GM	AUC
EQ	LUCE NE	0.66	0.91	0.09	0.25	0.99	0.28	0.59
	JDT	0.65	0.77	0.19	0.3	0.96	0.43	0.58
	MYL YN	0.63	0.69	0.14	0.23	0.96	0.37	0.55
	PDE	0.63	0.8	0.09	0.16	0.98	0.3	0.54
JDT	LUCE NE	0.78	0.38	0.12	0.18	0.75	0.34	0.54
	EQ	0.45	0.24	0.8	0.37	0.35	0.53	0.58
	MYL YN	0.89	0.28	0.82	0.39	0.79	0.55	0.59
	PDE	0.81	0.61	0.2	0.3	0.77	0.44	0.58
LUC ENE	EQ	0.63	0.14	0.06	0.22	0.63	0.59	0.6
	JDT	0.87	0.39	0.12	0.25	0.98	0.64	0.61
	MYL YN	0.87	0.11	0.06	0.08	0.95	0.24	0.5
	PDE	0.9	0.29	0.08	0.13	0.98	0.28	0.53
MYL YN	PDE	0.86	0.48	0.12	0.28	0.97	0.64	0.59

YN	EQ	0.64	0.18	0.5	0.26	0.66	0.57	0.58	MYL YN	PDE	0.84	0.38	0.41	0.37	0.92	0.59	0.66
	JDT	0.86	0.43	0.13	0.2	0.97	0.36	0.55		EQ	0.68	0.13	0.25	0.17	0.74	0.43	0.5
	LUCE NE	0.85	0.27	0.07	0.11	0.97	0.26	0.52		JDT	0.83	0.36	0.37	0.36	0.9	0.58	0.63
PDE	EQ	0.54	0.17	0.07	0.26	0.54	0.55	0.55	PDE	LUCE NE	0.68	0.18	0.4	0.25	0.72	0.54	0.56
	JDT	0.85	0.38	0.14	0.2	0.96	0.37	0.55		EQ	0.57	0.19	0.66	0.3	0.55	0.6	0.6
	LUCE NE	0.85	0.42	0.11	0.17	0.98	0.33	0.54		JDT	0.85	0.44	0.24	0.31	0.95	0.48	0.6
	MYL YN	0.86	0.44	0.15	0.27	0.98	0.38	0.55		LUCE NE	0.8	0.31	0.33	0.32	0.88	0.54	0.61
KC3	MC2	0.88	0.38	0.31	0.34	0.98	0.53	0.6	KC3	MYL YN	0.86	0.45	0.34	0.34	0.95	0.65	0.62
	PC3	0.8	0.38	0.08	0.13	0.97	0.28	0.53		MC2	0.8	0.44	0.22	0.39	0.94	0.45	0.58
	PC4	0.81	0	0	0	1	0	0.5		PC3	0.19	0.19	1	0.32	0.2	0.2	0.5
MC2	KC3	0.68	0.67	0.18	0.28	0.95	0.41	0.57	MC2	PC4	0.19	0.19	1	0.32	0.3	0.31	0.5
	PC3	0.66	0.58	0.16	0.25	0.94	0.39	0.55		KC3	0.66	0.6	0.07	0.53	0.98	0.26	0.52
	PC4	0.65	0	0	0	1	0	0.5		PC3	0.35	0.35	1	0.52	0	0	0.5
PC3	PC4	0.88	0.21	0.08	0.12	0.96	0.28	0.52	PC3	PC4	0.36	0.35	1	0.52	0.01	0.1	0.51
	KC3	0.87	0	0	0	1	0	0.5		PC4	0.89	0.27	0.19	0.22	0.93	0.42	0.56
	MC2	0.88	0.5	0.01	0.02	1	0.1	0.5		KC3	0.88	0	0	0	1	0	0.5
PC4	PC3	0.89	0.23	0.05	0.08	0.98	0.22	0.51	PC4	MC2	0.88	0	0	0	1	0	0.5
	KC3	0.88	1	0.01	0.02	1	0.1	0.5		PC3	0.86	0.26	0.06	0.1	0.98	0.24	0.52
	MC2	0.88	1	0.01	0.02	1	0.1	0.5		KC3	0.84	0	0	0	0.95	0	0.48
APACHE	SAFE	0.72	0.7	0.8	0.75	0.65	0.72	0.72	APACHE	MC2	0.8	0	0	0	0.92	0	0.46
	ZXIN G	0.64	0.64	0.68	0.66	0.6	0.64	0.64		SAFE	0.67	0.67	0.47	0.72	0.64	0.65	0.65
SAFE	ZXIN G	0.72	0.75	0.41	0.56	0.96	0.66	0.69	SAFE	ZXIN G	0.65	0.62	0.81	0.7	0.49	0.63	0.65
	APACHE	0.71	0.75	0.41	0.53	0.91	0.61	0.66		APACHE	0.39	0.39	1	0.56	0	0	0.5
ZXING	SAFE	0.69	0.46	0.18	0.27	0.92	0.4	0.55	ZXING	SAFE	0.68	0.37	0.11	0.47	0.92	0.32	0.52
	APACHE	0.69	0.45	0.18	0.26	0.91	0.4	0.54		APACHE	0.3	0.3	1	0.46	0	0	0.5

Table X. Comparison of Performance Metrics Using Logistic Regression Algorithm

TS	TR	ACC	PRE	REC	FM	SPEC	GM	AUC
EQ	LUCE NE	0.69	0.8	0.38	0.47	0.95	0.56	0.63
	JDT	0.63	0.62	0.18	0.28	0.93	0.41	0.55
	MYLY N	0.67	0.73	0.27	0.39	0.93	0.5	0.6
	PDE	0.69	0.77	0.32	0.45	0.94	0.55	0.63
JDT	LUCE NE	0.8	0.51	0.45	0.48	0.89	0.63	0.67
	EQ	0.4	0.24	0.87	0.38	0.27	0.48	0.57
	MYL YN	0.88	0.59	0.87	0.52	0.53	0.67	0.69
	PDE	0.81	0.55	0.48	0.51	0.9	0.66	0.69
LUC ENE	EQ	0.73	0.17	0.48	0.25	0.75	0.6	0.62
	JDT	0.9	0.36	0.19	0.27	0.97	0.62	0.67
	MYLY N	0.89	0.32	0.17	0.22	0.96	0.4	0.57
	PDE	0.87	0.32	0.33	0.32	0.93	0.55	0.63

Table XI. Comparison of Performance Metrics Using Naïve Bayes Algorithm

TS	TR	ACC	PRE	REC	FM	SPEC	GM	AUC
EQ	LUCE NE	0.72	0.84	0.46	0.58	0.96	0.68	0.67
	JDT	0.69	0.83	0.26	0.4	0.96	0.5	0.61
	MYLY N	0.71	0.76	0.4	0.52	0.92	0.61	0.66
	PDE	0.71	0.79	0.36	0.49	0.94	0.58	0.65
JDT	LUCE NE	0.51	0.29	0.91	0.44	0.41	0.61	0.66
	EQ	0.41	0.25	0.94	0.39	0.28	0.51	0.61
	MYL YN	0.54	0.32	0.85	0.46	0.46	0.63	0.68
	PDE	0.54	0.3	0.89	0.45	0.45	0.63	0.67
LUC ENE	EQ	0.77	0.22	0.59	0.32	0.79	0.68	0.69
	JDT	0.89	0.39	0.27	0.38	0.96	0.69	0.69
	MYLY	0.87	0.33	0.42	0.37	0.91	0.62	0.67

	N							
	PDE	0.86	0.32	0.45	0.37	0.9	0.64	0.68
MYL YN	PDE	0.77	0.33	0.67	0.45	0.82	0.64	0.67
	EQ	0.3	0.13	0.79	0.22	0.23	0.43	0.51
	JDT	0.74	0.24	0.44	0.31	0.78	0.59	0.61
	LUCE NE	0.51	0.29	0.91	0.44	0.41	0.61	0.66
PDE	EQ	0.63	0.21	0.61	0.31	0.64	0.62	0.62
	JDT	0.84	0.38	0.29	0.33	0.92	0.52	0.61
	LUCE NE	0.77	0.29	0.47	0.36	0.82	0.62	0.64
	MYL YN	0.85	0.39	0.43	0.37	0.96	0.62	0.64
KC3	MC2	0.8	0.44	0.19	0.37	0.99	0.42	0.57
	PC3	0.8	0	0	0	0.99	0	0.49
	PC4	0.2	0.19	1	0.32	0.02	0.14	0.51
MC2	KC3	0.73	0.66	0.48	0.56	0.89	0.64	0.67
	PC3	0.58	0	0	0	0.89	0	0.44
	PC4	0.42	0.38	1	0.55	0.11	0.33	0.56
PC3	PC4	0.89	0.25	0.12	0.26	1	0.34	0.53
	KC3	0.14	0.13	1	0.23	0.02	0.14	0.51
	MC2	0.88	0	0	0	1	0	0.5
PC4	PC3	0.25	0.14	0.97	0.24	0.15	0.48	0.58
	KC3	0.28	0.14	0.96	0.24	0.18	0.42	0.57
	MC2	0.87	0	0	0	1	0	0.5
APACHE	SAFE	0.72	0.69	0.87	0.75	0.62	0.71	0.72
	ZXING	0.66	0.62	0.86	0.72	0.46	0.63	0.66
SAFE	ZXING	0.7	0.6	0.68	0.64	0.71	0.69	0.69
	APACHE	0.61	0	0	0	1	0	0.5
ZXING	SAFE	0.7	0.49	0.19	0.27	0.91	0.42	0.55
	APACHE	0.7	0	0	0	1	0	0.5

Table XII. Comparison of Performance Metrics Using SVM Algorithm

ENE	JDT	0.92	0.3	0.05	0.39	0.99	0.22	0.64
	MYLY N	0.9	0	0	0	0.99	0	0.5
	PDE	0.91	0	0	0	1	0	0.5
MYL YN	PDE	0.87	0	0.4	0.4	1	0	0.65
	EQ	0.81	0.3	0.36	0.33	0.87	0.56	0.62
	JDT	0.87	0.53	0.03	0.06	1	0.17	0.51
	LUCE NE	0.87	0.5	0	0	1	0	0.5
PDE	EQ	0.73	0.25	0.48	0.33	0.77	0.61	0.62
	JDT	0.86	0.62	0.02	0.04	1	0.14	0.51
	LUCE NE	0.86	0	0	0	1	0	0.5
	MYL YN	0.86	0.69	0.52	0.44	0.99	0.14	0.51
KC3	MC2	0.81	0.47	0.19	0.27	0.95	0.42	0.57
	PC3	0.81	0	0	0	1	0	0.5
	PC4	0.81	0	0	0	1	0	0.5
MC2	KC3	0.65	0	0	0	1	0	0.5
	PC3	0.65	0	0	0	1	0	0.5
	PC4	0.65	0	0	0	1	0	0.5
PC3	PC4	0.89	0	0	0	1	0	0.5
	KC3	0.88	0	0	0	1	0	0.5
	MC2	0.85	0.12	0.04	0.06	0.96	0.2	0.5
PC4	PC3	0.88	0	0	0	1	0	0.5
	KC3	0.88	0	0	0	1	0	0.5
	MC2	0.86	0.2	0.04	0.07	0.98	0.2	0.51
APACHE	SAFE	0.73	0.69	0.84	0.76	0.62	0.72	0.73
	ZXING	0.48	0.29	0.02	0.04	0.95	0.14	0.48
SAFE	ZXING	0.66	0.8	0.18	0.29	0.97	0.42	0.58
	APACHE	0.39	0.39	1	0.56	0	0	0.5
ZXING	SAFE	0.72	0.59	0.14	0.23	0.96	0.37	0.55
	APACHE	0.3	0.3	1	0.46	0	0	0.5

V. CONCLUSION

In this paper, we applied the algorithm to balance imbalanced datasets and Centroid based relevant project selection algorithm for Cross Project Defect Prediction. The AEEM, Re-Link, and NASA open-source software defect datasets are taken into consideration for experimentation. The experimentation results after applying various algorithms on the datasets related to different projects shows that, except some metrics, most of the metrics are giving good performance for the combination of test and train datasets.

In future, we would like to consider more datasets from various open-source projects for experimentation.

TS	TR	ACC	PRE	REC	FM	SPEC	GM	AUC
EQ	LUCE NE	0.65	0	0	0	1	0.5	0.55
	JDT	0.64	1	0.09	0.17	1	0.3	0.54
	MYLY N	0.62	0.86	0.05	0.09	0.99	0.22	0.52
	PDE	0.61	1	0.02	0.04	1	0.14	0.51
JDT	LUCE NE	0.8	1	0.01	0.02	1	0.1	0.5
	EQ	0.56	0.29	0.08	0.12	0.51	0.3	0.64
	MYL YN	0.81	1	0.09	0.16	1	0.3	0.54
	PDE	0.79	0.5	0	0	1	0	0.5
LUC	EQ	0.81	0.22	0.42	0.29	0.85	0.6	0.63

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